

**Low  $V_{CE(SAT)}$  NPN / PNP Epitaxial Planar Transistors**

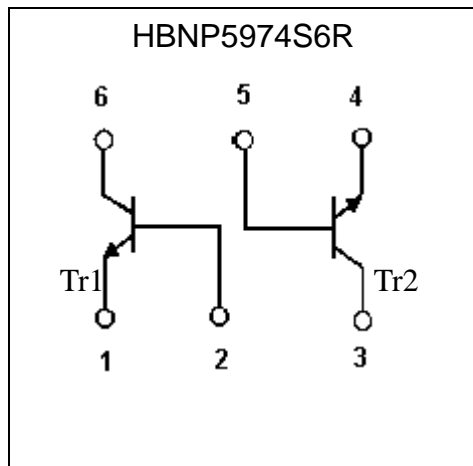
# HBNP5974S6R

**(Dual Transistors)**

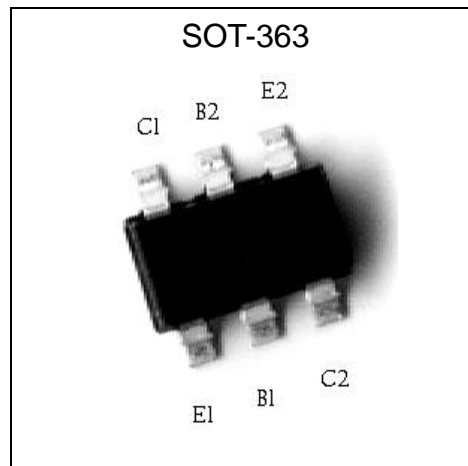
**Features**

- One NPN chip and one PNP chip in a SOT-363 package.
- Mounting possible with SOT-323 automatic mounting machines.
- Transistor elements are independent, eliminating interference.
- Mounting cost and area can be cut in half.
- Low  $V_{CE(sat)}$
- Weight : 9.1mg, approximately.
- Pb-free lead plating and halogen-free package.

**Equivalent Circuit**

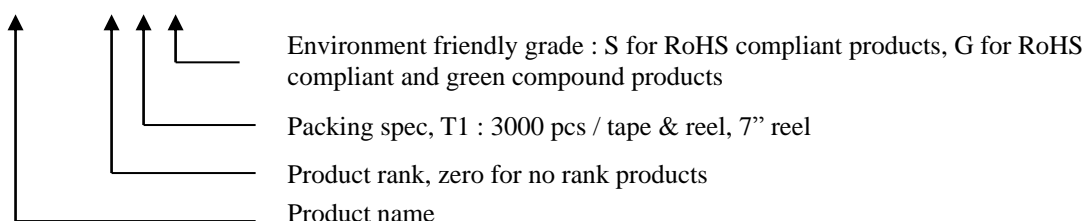


**Outline**



**Ordering Information**

Device	Package	Shipping
HBNP5974S6R-0-T1-G	SOT-363 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel





The following characteristics apply to both Tr1 and Tr2

**Absolute Maximum Ratings** (Ta=25°C)

Parameter	Symbol	Limits		Unit
		TR1 (NPN)	TR2 (PNP)	
Collector-Base Voltage	V <sub>CBO</sub>	40	-40	V
Collector-Emitter Voltage	V <sub>CEO</sub>	20	-20	V
Emitter-Base Voltage	V <sub>EBO</sub>	6	-6	V
Collector Current	I <sub>C</sub>	800	-800	mA
Collector Current (Pulse)	I <sub>CP</sub> (Note 1)	1.5	-1.5	A
Power Dissipation	P <sub>D</sub> (Note 2)	200(total)		mW
Operating Junction Temperature Range	T <sub>j</sub>	-55~+150		°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150		°C

Note : 1.Single pulse, Pw=10ms  
 2.150mW per element must not be exceeded.

**Characteristics** (Ta=25°C)

**Tr 1 (NPN)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
BV <sub>CBO</sub>	40	-	-	V	I <sub>C</sub> =100μA, I <sub>E</sub> =0
BV <sub>CEO</sub>	20	-	-	V	I <sub>C</sub> =1mA, I <sub>B</sub> =0
BV <sub>EBO</sub>	6	-	-	V	I <sub>E</sub> =100μA, I <sub>C</sub> =0
I <sub>CBO</sub>	-	-	100	nA	V <sub>CB</sub> =40V, I <sub>E</sub> =0
I <sub>EBO</sub>	-	-	100	nA	V <sub>EB</sub> =6V, I <sub>C</sub> =0
*V <sub>CE(sat)1</sub>	-	-	25	mV	I <sub>C</sub> =10mA, I <sub>B</sub> =0.5mA
*V <sub>CE(sat)2</sub>	-	-	150	mV	I <sub>C</sub> =200mA, I <sub>B</sub> =10mA
*V <sub>CE(sat)3</sub>	-	-	250	mV	I <sub>C</sub> =500mA, I <sub>B</sub> =50mA
*R <sub>CE(sat)</sub>	-	-	500	mΩ	I <sub>C</sub> =500mA, I <sub>B</sub> =50mA
*V <sub>BE(sat)</sub>	-	-	1.1	V	I <sub>C</sub> =500mA, I <sub>B</sub> =50mA
*V <sub>BE(on)</sub>	-	-	0.9	V	V <sub>CE</sub> =2V, I <sub>C</sub> =100mA
*h <sub>FE1</sub>	180	-	-	-	V <sub>CE</sub> =2V, I <sub>C</sub> =10mA
*h <sub>FE2</sub>	180	-	360	-	V <sub>CE</sub> =2V, I <sub>C</sub> =100mA
*h <sub>FE3</sub>	90	-	-	-	V <sub>CE</sub> =2V, I <sub>C</sub> =500mA
f <sub>T</sub>	100	300	-	MHz	V <sub>CE</sub> =10V, I <sub>C</sub> =50mA, f=100MHz
C <sub>ob</sub>	-	6.5	-	pF	V <sub>CB</sub> =10V, f=1MHz

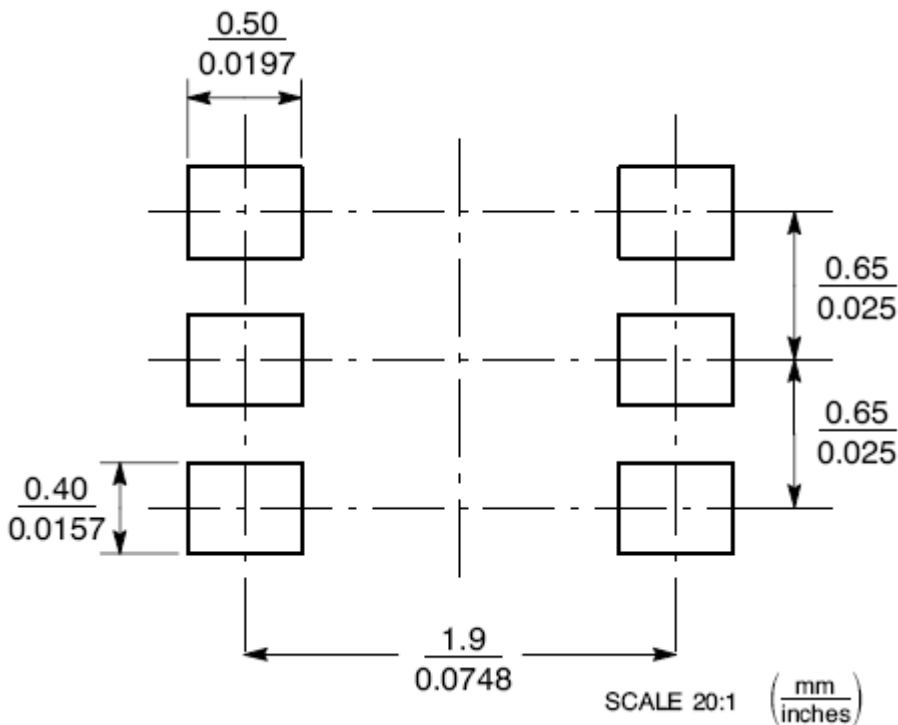
\*Pulse Test : Pulse Width ≤380μs, Duty Cycle≤2%

**Tr 2 (PNP)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
BV <sub>CBO</sub>	-40	-	-	V	I <sub>C</sub> =-50μA, I <sub>E</sub> =0
BV <sub>CEO</sub>	-20	-	-	V	I <sub>C</sub> =-1mA, I <sub>B</sub> =0
BV <sub>EBO</sub>	-6	-	-	V	I <sub>E</sub> =-50μA, I <sub>C</sub> =0
I <sub>CBO</sub>	-	-	-100	nA	V <sub>CB</sub> =-40V, I <sub>E</sub> =0
I <sub>EBO</sub>	-	-	-100	nA	V <sub>EB</sub> =-6V, I <sub>C</sub> =0
*V <sub>CE(sat)1</sub>	-	-	-50	mV	I <sub>C</sub> =-10mA, I <sub>B</sub> =-0.5mA
*V <sub>CE(sat)2</sub>	-	-	-150	mV	I <sub>C</sub> =-200mA, I <sub>B</sub> =-10mA
*V <sub>CE(sat)3</sub>	-	-	-250	mV	I <sub>C</sub> =-500mA, I <sub>B</sub> =-50mA
*R <sub>CE(sat)</sub>	-	-	500	mΩ	I <sub>C</sub> =-500mA, I <sub>B</sub> =-50mA
*V <sub>BE(sat)</sub>	-	-	-1.1	V	I <sub>C</sub> =-500mA, I <sub>B</sub> =-50mA
*V <sub>BE(on)</sub>	-	-	-0.9	V	V <sub>CE</sub> =-2V, I <sub>C</sub> =-100mA
*h <sub>FE1</sub>	180	-	-	-	V <sub>CE</sub> =-2V, I <sub>C</sub> =-10mA
*h <sub>FE2</sub>	150	-	300	-	V <sub>CE</sub> =-2V, I <sub>C</sub> =-100mA
*h <sub>FE3</sub>	90	-	-	-	V <sub>CE</sub> =-2V, I <sub>C</sub> =-500mA
f <sub>T</sub>	-	270	-	MHz	V <sub>CE</sub> =-5V, I <sub>C</sub> =-50mA, f=100MHz
C <sub>ob</sub>	-	12	-	pF	V <sub>CB</sub> =10V, f=1MHz

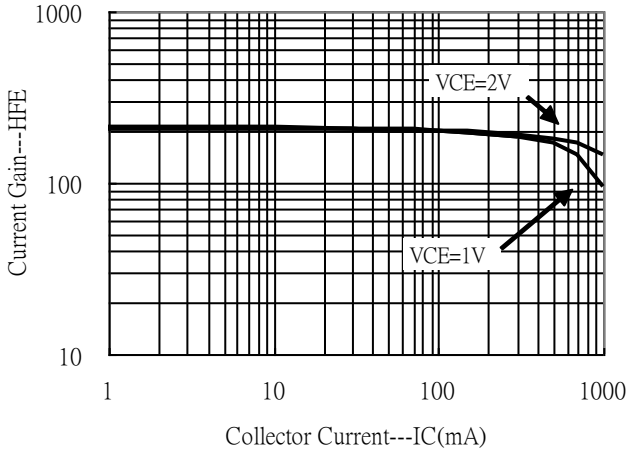
\*Pulse Test : Pulse Width ≤380μs, Duty Cycle≤2%

**Recommended Soldering Footprint**

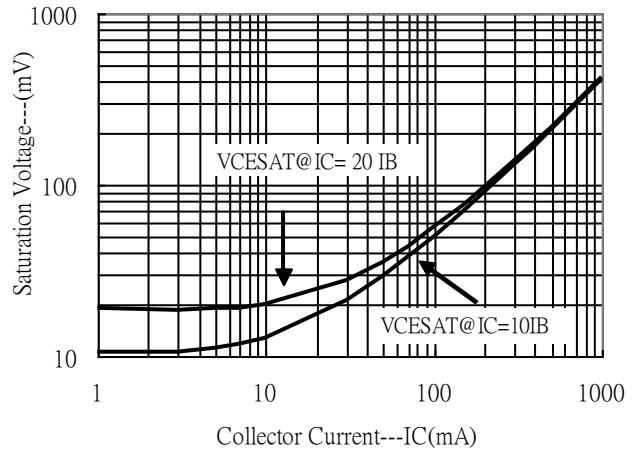


**Typical Characteristics (Tr1, NPN)**

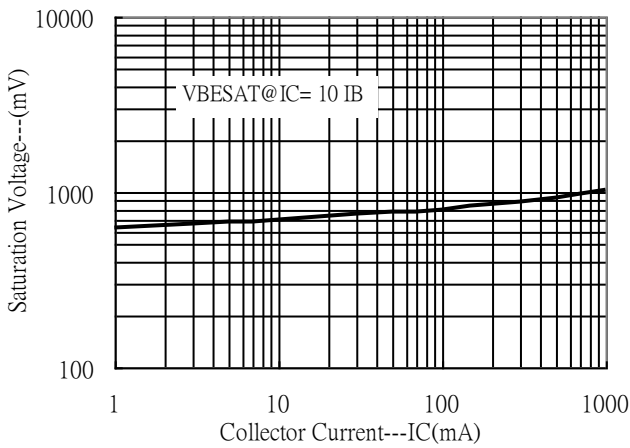
Current Gain vs Collector Current



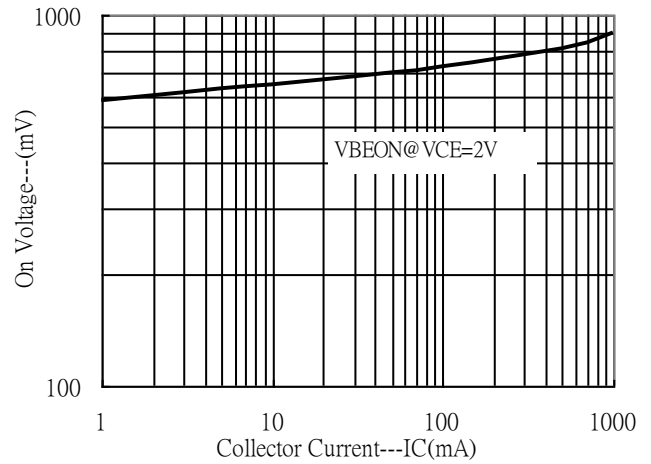
Saturation Voltage vs Collector Current



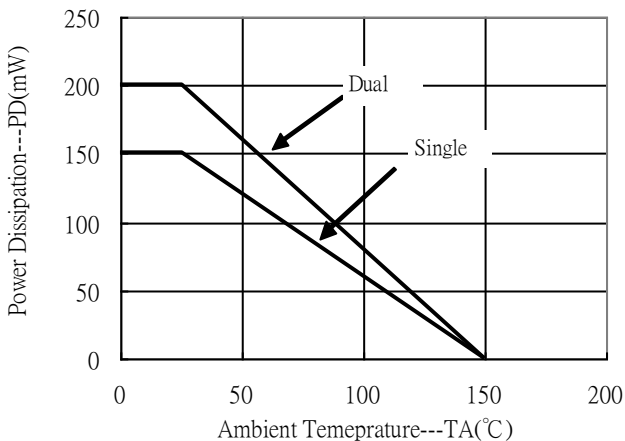
Saturation Voltage vs Collector Current



On Voltage vs Collector Current



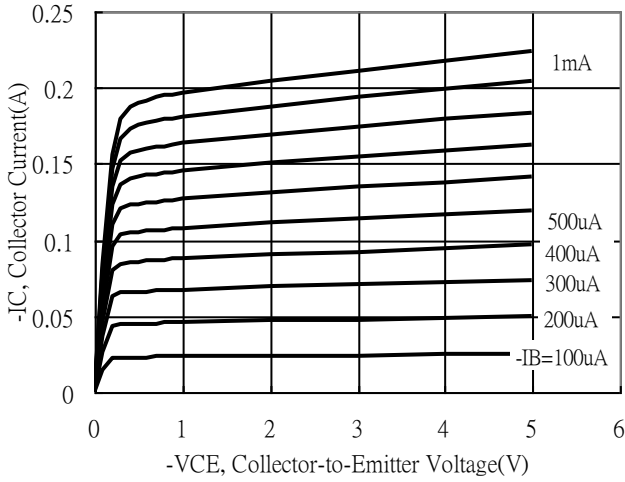
Power Derating Curve



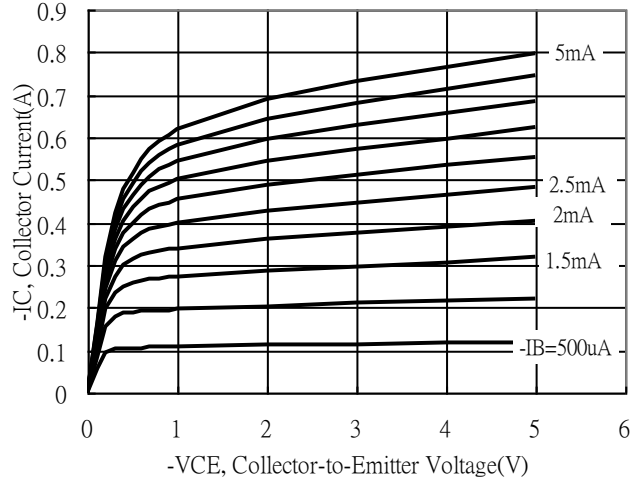


### Typical Characteristics(Tr2, PNP)

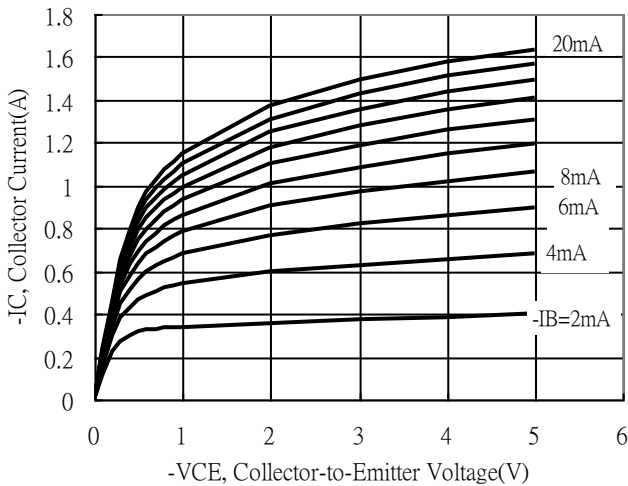
Emitter Grounded Output Characteristics



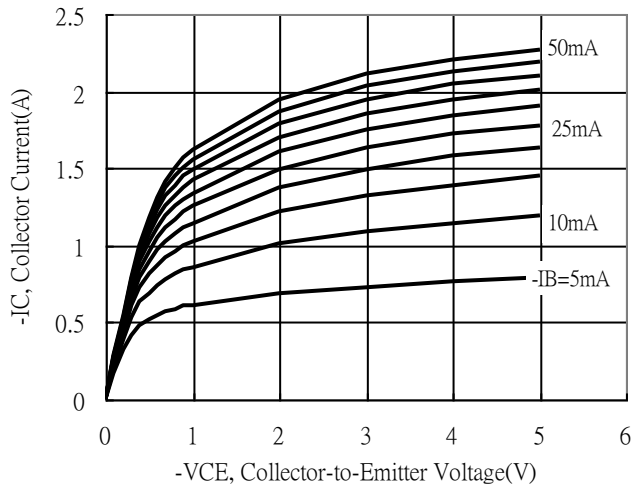
Emitter Grounded Output Characteristics



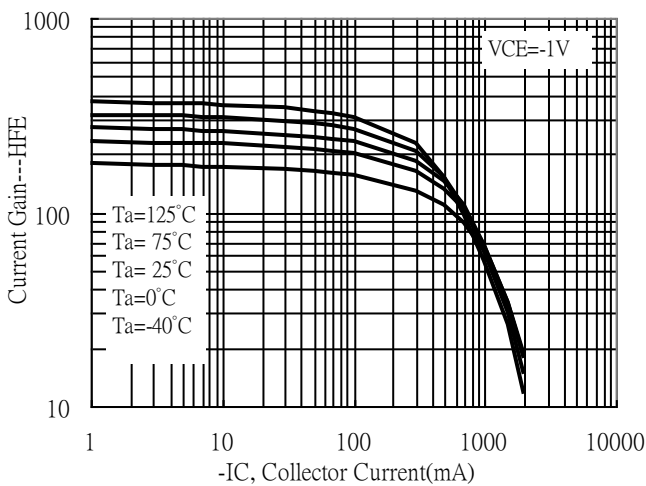
Emitter Grounded Output Characteristics



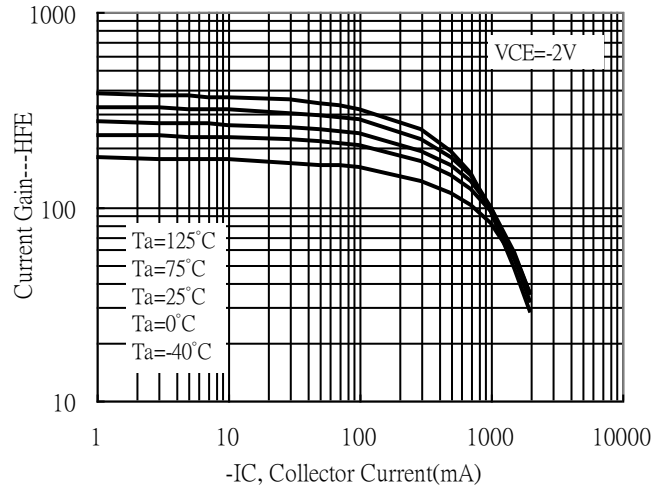
Emitter Grounded Output Characteristics



Current Gain vs Collector Current

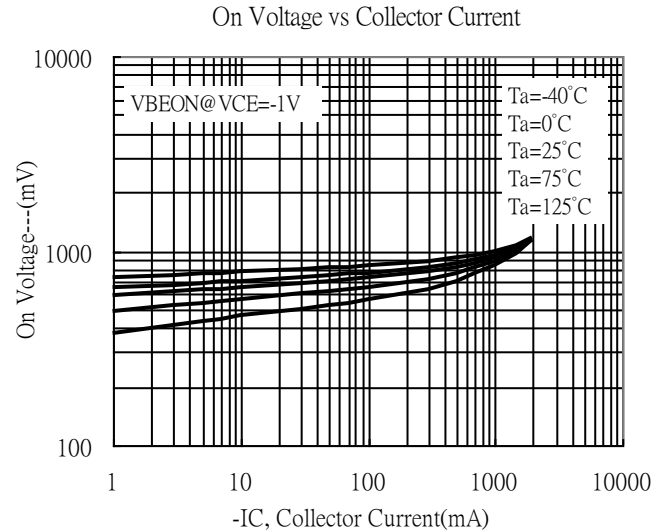
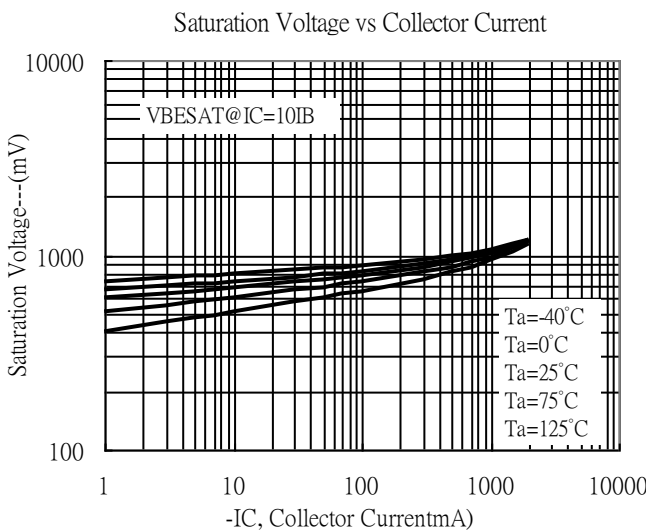
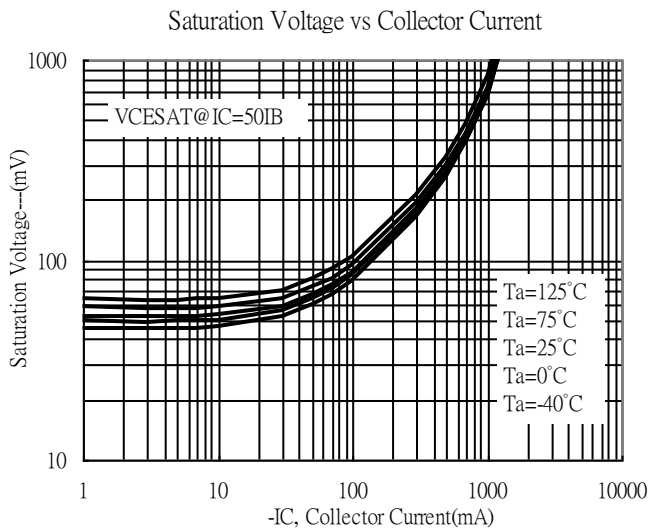
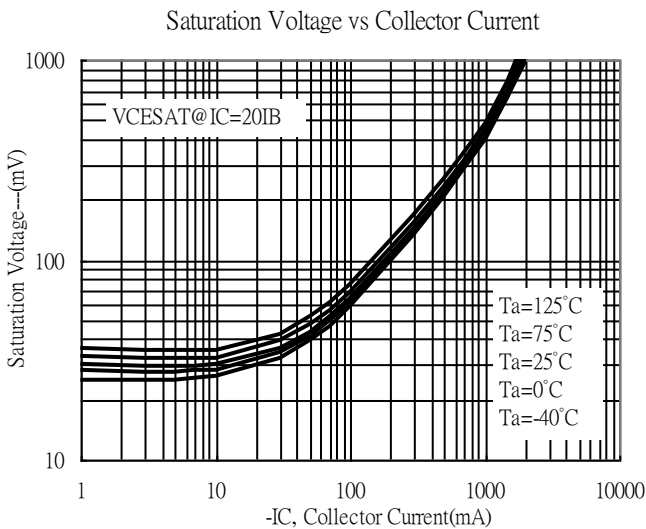
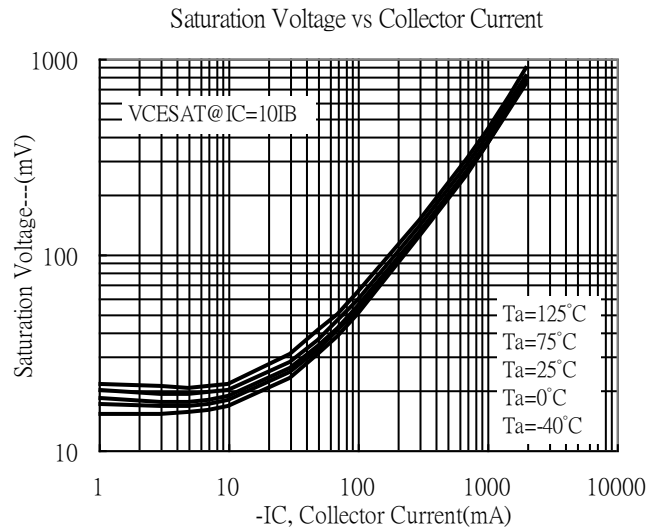
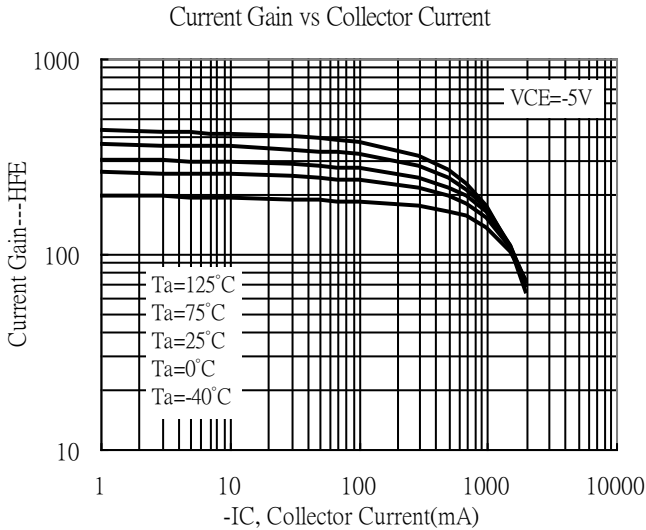


Current Gain vs Collector Current



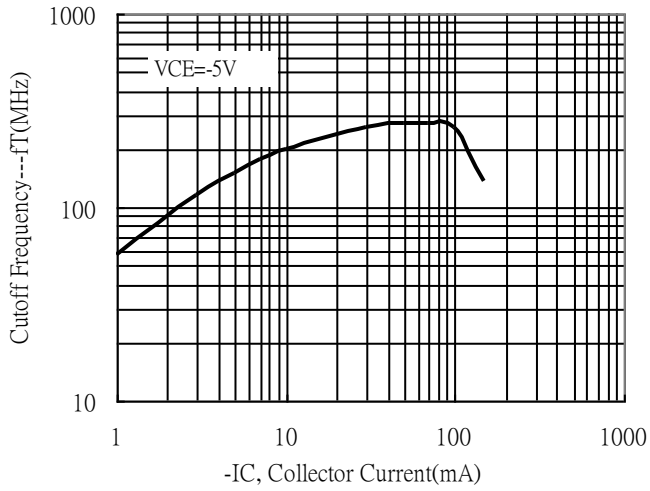


### Typical Characteristics(Cont.)(Tr2, PNP)

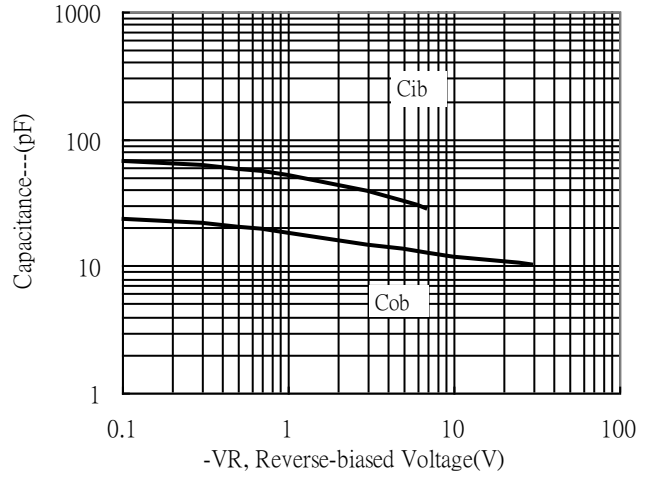


**Typical Characteristics(Cont.)(Tr2, PNP)**

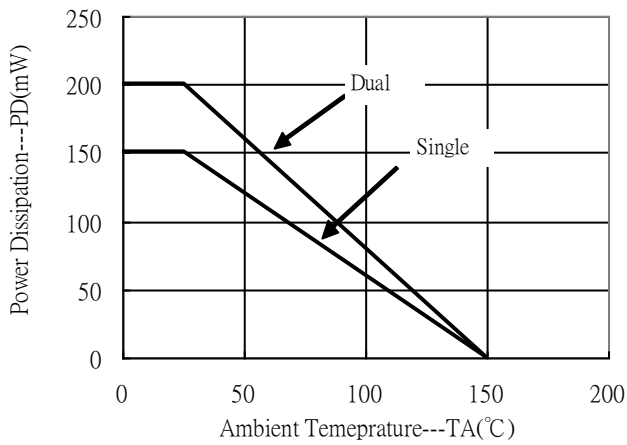
Cutoff Frequency vs Collector Current



Capacitance vs Reverse-biased Voltage



Power Derating Curve



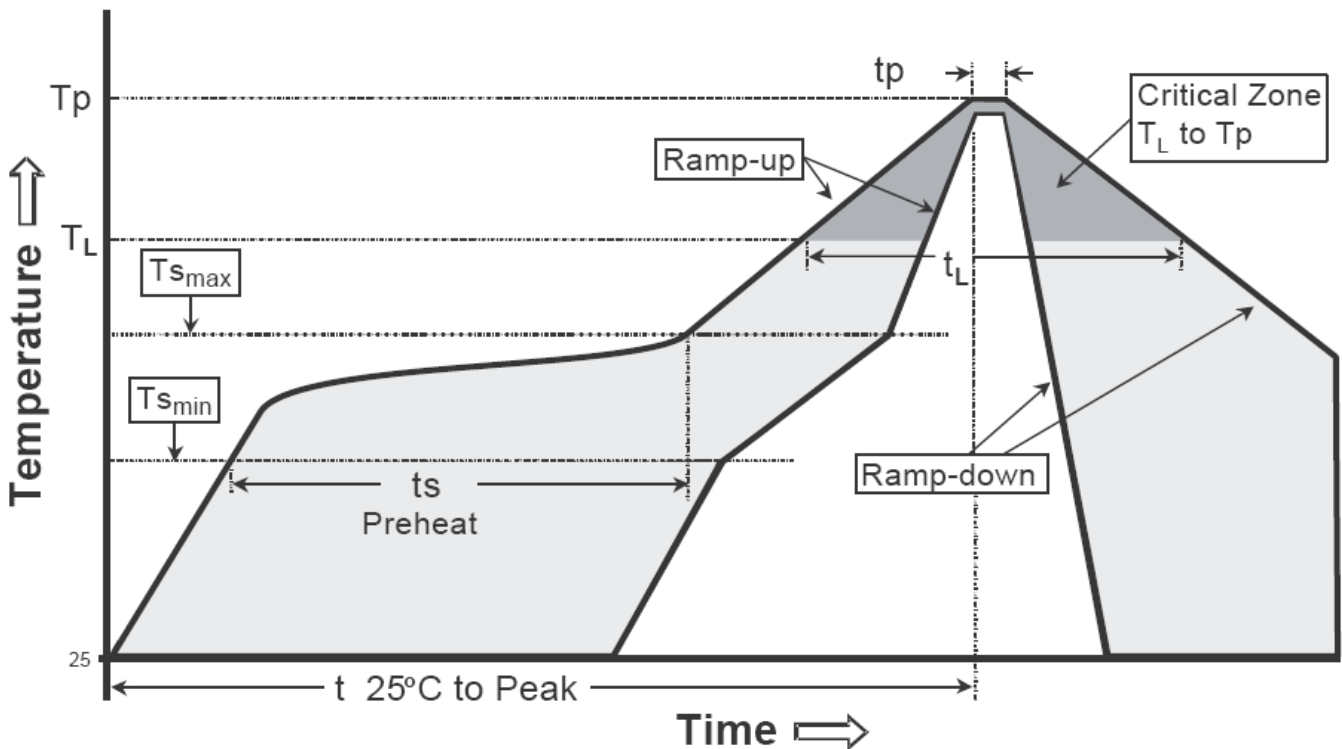




**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

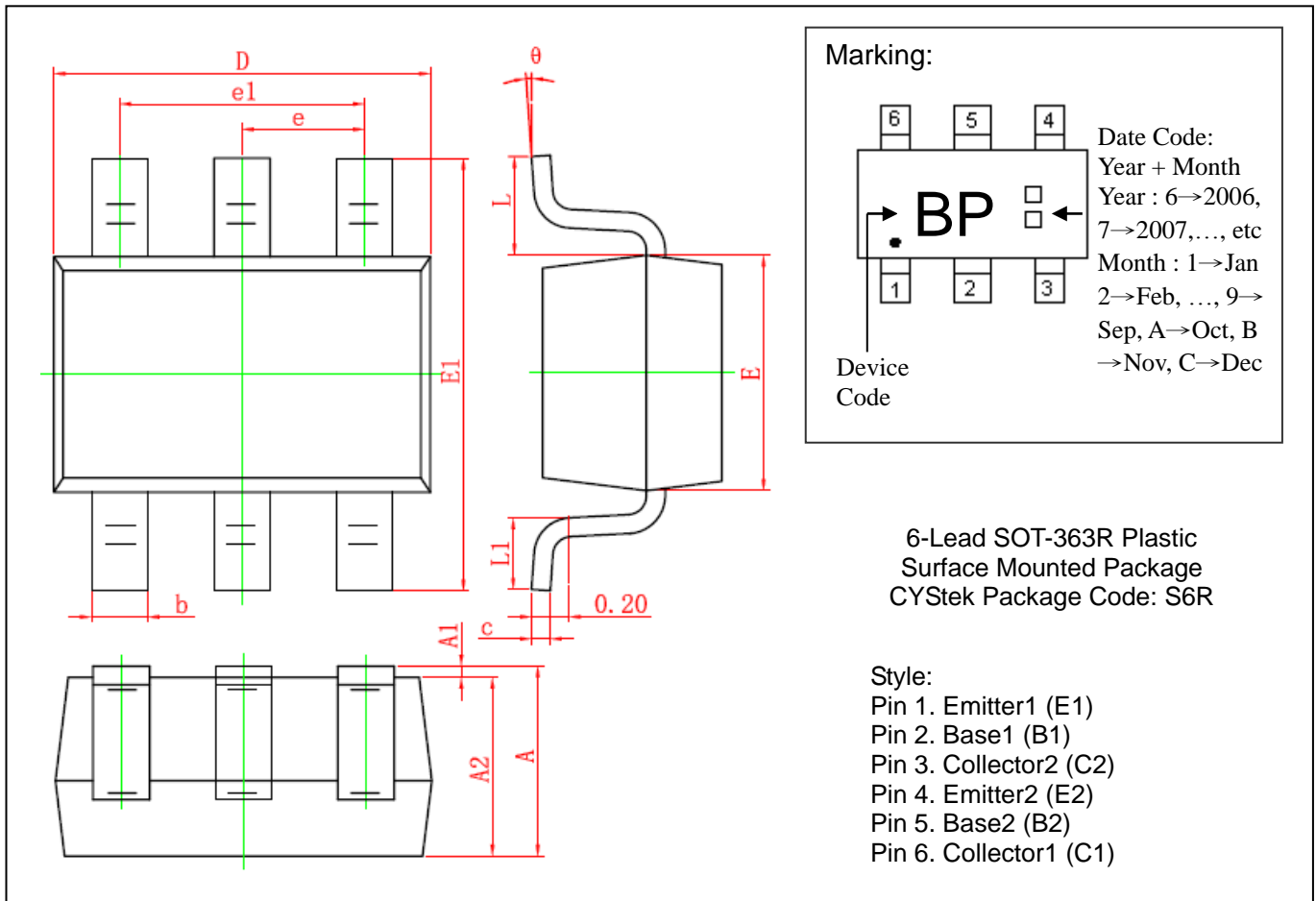
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>p</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(t <sub>p</sub> )	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**SOT-363 Dimension**



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043	E1	2.150	2.450	0.085	0.096
A1	0.000	0.100	0.000	0.004	e	0.650 TYP		0.026	TYP
A2	0.900	1.000	0.035	0.039	e1	1.200	1.400	0.047	0.055
b	0.150	0.350	0.006	0.014	L	0.525 REF		0.021	REF
c	0.080	0.150	0.003	0.006	L1	0.260	0.460	0.010	0.018
D	2.000	2.200	0.079	0.087	θ	0°	8°	0°	8°
E	1.150	1.350	0.045	0.053					

**Notes :** 1.Controlling dimension : millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material :**

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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